


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578133	<b>Applicant(s)/Patent Under Reexamination</b>  SHIN ET AL.
	<b>Examiner</b>  Leigh C Maier	<b>Art Unit</b>  1623

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	1/26/09	LCM
EAST	10/9/09	LCM

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
514	54	10/23/09	LCM

	/Leigh C Maier/ Primary Examiner.Art Unit 1623
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